


<b>Search Notes</b>  	<b>Application/Control No.</b>  10561252	<b>Applicant(s)/Patent Under Reexamination</b>  WATANABE ET AL.
	<b>Examiner</b>  YUBIN HUNG	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	164, 171, 173, 236	1/2/09	YH
348	400.1	1/2/09	YH
375	240.16	1/2/09	YH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB)	2/12/09	YH
Inventor search (EAST/eDAN)	1/2/09	YH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/YUBIN HUNG/ Primary Examiner.Art Unit 2624
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